



P-Channel 1.8 V (G-S) MOSFET

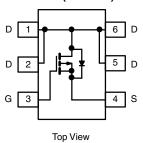
PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)		
- 20	0.195 at V _{GS} = - 4.5 V	- 0.84		
	0.260 at V _{GS} = - 2.5 V	- 0.73		
	0.350 at V _{GS} = - 1.8 V	- 0.64		

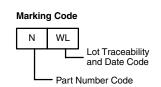
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- Low Threshold
- Smallest LITTLE FOOT[®] Package: 1.6 mm x 1.6 mm
- Low 0.6 mm Profile
- Compliant to RoHS Directive 2002/95/EC



SC-89 (6-LEADS)





Ordering Information: Si1037X-T1-GE3 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

- Cell Phones and Pagers
 - Load Switch
- · Battery Operated Systems

ABSOLUTE MAXIMUM RATINGS	(T _A = 25 °C, unle	ess otherwise	noted)		
Parameter		Symbol	5 s	Steady State	Unit
Drain-Source Voltage		V _{DS}	- 20		V
Gate-Source Voltage		V _{GS}	± 8		
Continuous Dunis Courset /T. 150 °C\\	T _A = 25 °C	- I _D	- 0.84	- 0.77	^
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 70 °C		- 0.68	- 0.62	
Pulsed Drain Current		I _{DM}	- 4		Α
Continuous Diode Current (Diode Conduction) ^a		I _S	- 0.18	- 0.14	
Mariana Barra Birainatina	T _A = 25 °C	- P _D	0.21	0.17	- W
Maximum Power Dissipation ^a	T _A = 70 °C		0.13	0.10	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^a	t ≤ 5 s	R _{thJA}	500	600	°C/W	
	Steady State		600	720		

Notes:

a. Surface mounted on 1" x 1" FR4 board with minimum copper.

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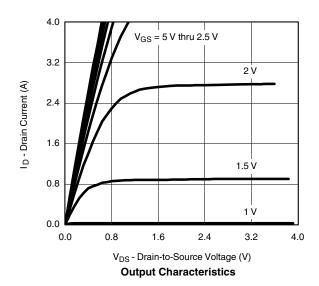
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.45			V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V			- 1	μΑ	
		V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 70 °C			- 5		
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 4.5 V	- 4			Α	
		V _{GS} = - 4.5 V, I _D = - 0.77 A		0.160	0.195		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 0.67 A		0.212	0.260	Ω	
		V _{GS} = - 1.8 V, I _D = - 0.2 A		0.290	0.350		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 0.77 A		3.1		S	
Diode Forward Voltage ^a	V_{SD}	I _S = - 0.14 A, V _{GS} = 0 V		- 0.78	- 1.2	V	
Dynamic ^b							
Total Gate Charge	Qg			3.5	5.5	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -0.77 \text{ A}$		0.65			
Gate-Drain Charge	Q_{gd}			0.60			
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 20 Ω		15	30		
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong -0.5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_{G} = 6 \Omega$		30	60	ns	
Fall Time	t _f			10	20		
Source-Drain Reverse Recovery Time	t _{rr}	I _F = - 0.14 A, dl/dt = 100 A/μs		20	40		

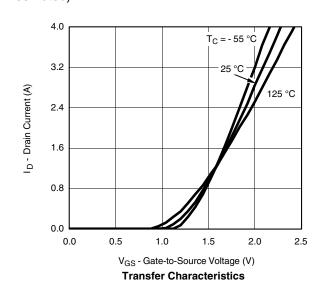
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

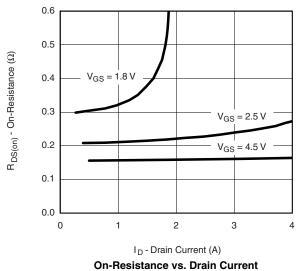


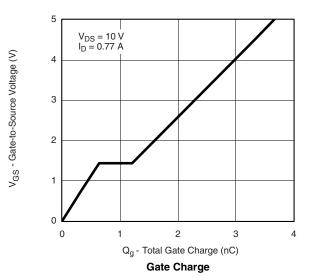


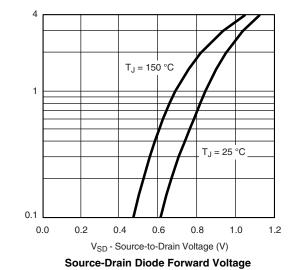


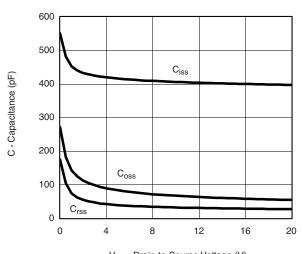


TYPICAL CHARACTERISTICS ($T_A = 25$ °C, unless otherwise noted)



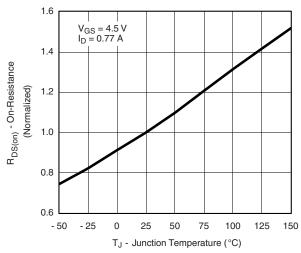




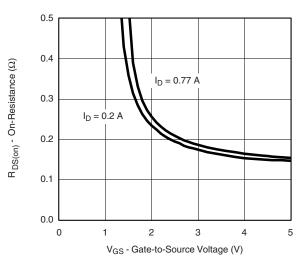


V_{DS} - Drain-to-Source Voltage (V)





On-Resistance vs. Junction Temperature



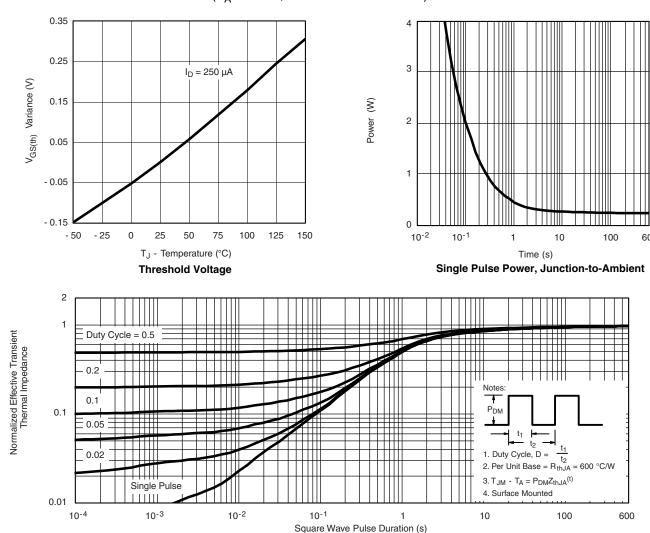
On-Resistance vs. Gate-to-Source Voltage

Is - Source Current (A)

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TYPICAL CHARACTERISTICS ($T_A = 25$ °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

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